

Product Summary

$V_{(BR)DSS}$	$R_{DS(on)MAX}$	I_D
30V	21mΩ@10V	5.6A
	25mΩ@4.5V	
	41mΩ@2.5V	

Feature

- Trench Power MOSFET technology
- High Speed switching
- High density cell design for low $R_{DS(ON)}$

Application

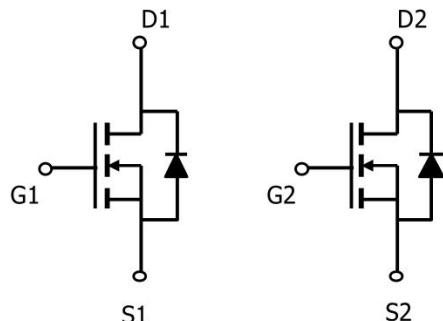
- Battery protection
- Load switch
- Power management

Package



SOP-8

Circuit diagram



Marking



Absolute maximum ratings (T_A=25°C unless otherwise noted)

Parameter	Symbol	Value	Unit
Drain-Source Voltage	V _{DS}	30	V
Gate-Source Voltage	V _{GS}	±12	V
Continuous Drain Current	I _D	5.6	A
Continuous Drain Current (T _A =100°C)	I _D (100°C)	3.5	A
Pulsed Drain Current ¹⁾	I _{DM}	40	A
Power Dissipation ²⁾	P _D	1.25	W
Thermal Resistance from Junction to Ambient ³⁾	R _{θJA}	100	°C/W
Junction Temperature	T _J	150	°C
Storage Temperature	T _{STG}	-55 ~ +150	°C

Electrical characteristics (T_J=25 °C, unless otherwise noted)

Parameter	Symbol	Test Condition	Min.	Typ.	Max.	Unit
Static Characteristics						
Drain-source breakdown voltage	V _{(BR)DSS}	V _{GS} = 0V, I _D = 250μA	30			V
Zero gate voltage drain current	I _{DSS}	V _{DS} = 30V, V _{GS} = 0V			1	μA
Gate-body leakage current	I _{GSS}	V _{GS} = ±12V, V _{DS} = 0V			±100	nA
Gate threshold voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = 250μA	0.65	0.9	1.5	V
Drain-source on-resistance	R _{DS(on)}	V _{GS} = 10V, I _D = 5.6A		16	21	mΩ
		V _{GS} = 4.5V, I _D = 3A		19	25	
		V _{GS} = 2.5V, I _D = 1.5A		27	41	
Dynamic characteristics⁴⁾						
Input Capacitance	C _{iss}	V _{DS} = 15V, V _{GS} = 0V, f = 1MHz		610		pF
Output Capacitance	C _{oss}			60		
Reverse Transfer Capacitance	C _{rss}			50		
Total Gate Charge	Q _g	V _{DS} = 15V, V _{GS} = 10V, I _D = 5.6A		16		nC
Gate-Source Charge	Q _{gs}			2.4		
Gate-Drain Charge	Q _{gd}			2		
Turn-on delay time	t _{d(on)}	V _{DD} = 15V, V _{GS} = 10V, I _D = 5.6A R _{GEN} = 3Ω		6		nS
Turn-on rise time	t _r			28		
Turn-off delay time	t _{d(off)}			16		
Turn-off fall time	t _f			12		
Source-Drain Diode characteristics						
Diode Forward Current	I _S				5.6	A
Diode Forward voltage	V _{SD}	V _{GS} = 0V, I _S = 5.6A			1.2	V
Reverse recover time	T _{rr}	I _F = 5.6A, di/dt = 100A/us		8.5		nS
Reverse recovery charge	Q _{rr}			4.5		nC

Notes:

- 1) Repetitive rating; pulse width limited by max. junction temperature.
- 2) P_d is based on max. junction temperature, using junction-ambient thermal resistance.
- 3) The value of R_{θJA} is measured with the device mounted on the minimum recommend pad size, in the still air environment with T_A = 25°C. The maximum allowed junction temperature of 150°C. The value in any given application depends on the user's specific board design.
- 4) Guaranteed by design, not subject to production testing.

Typical Characteristics

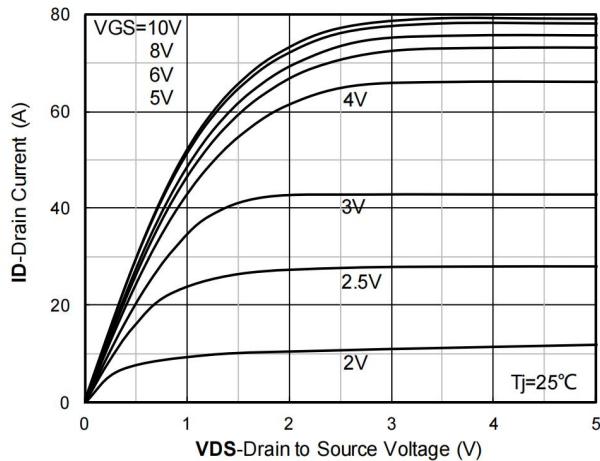


Figure 1. Output Characteristics

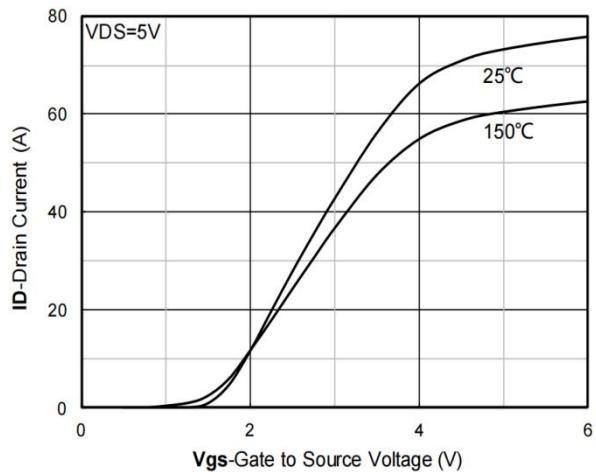


Figure 2. Transfer Characteristics

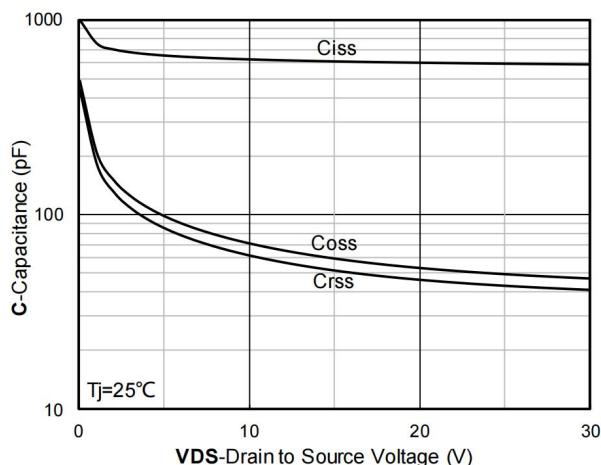


Figure 3. Capacitance Characteristics

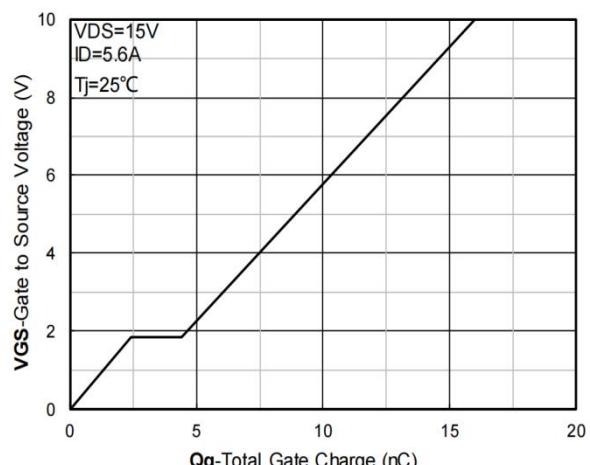


Figure 4. Gate Charge

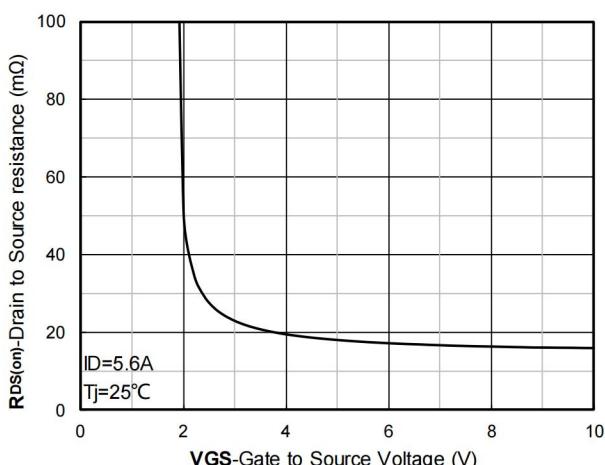


Figure 5. On-Resistance vs Gate to Source Voltage

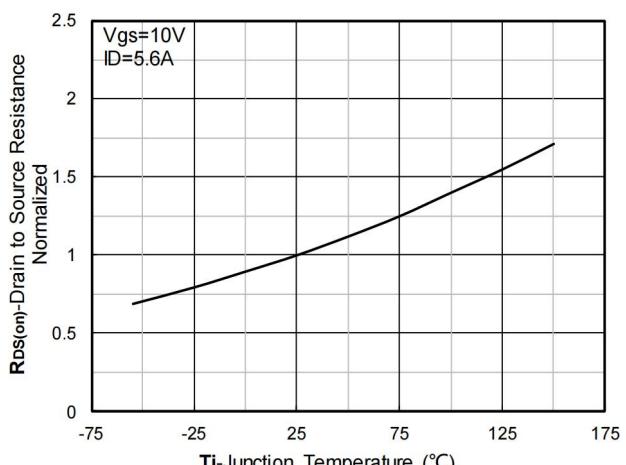


Figure 6. Normalized On-Resistance

Typical Characteristics

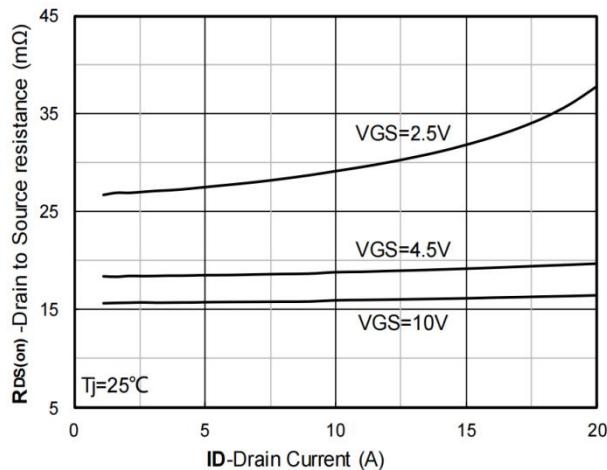


Figure 7. RDS(on) VS Drain Current

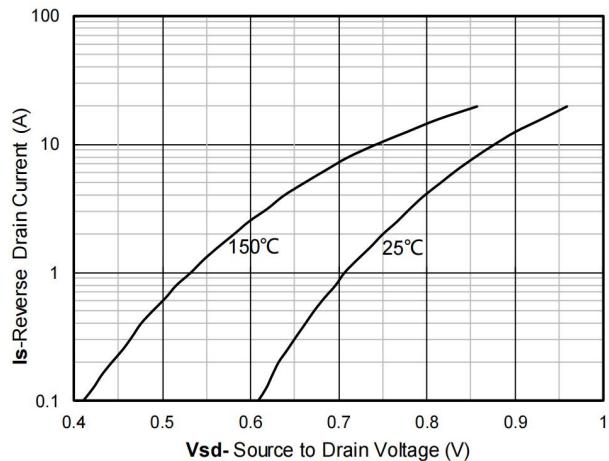


Figure 8. Forward characteristics of reverse diode

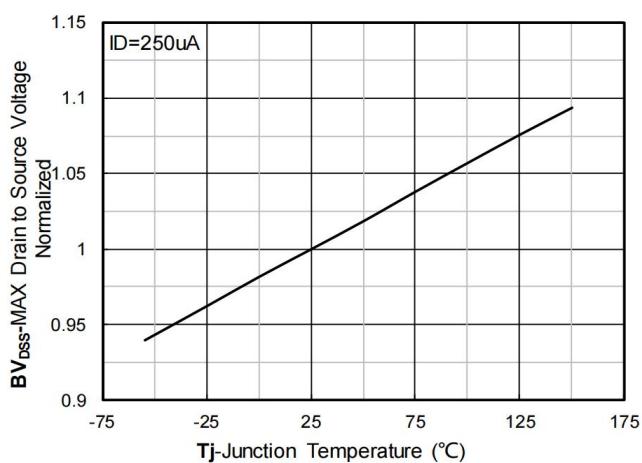


Figure 9. Normalized breakdown voltage

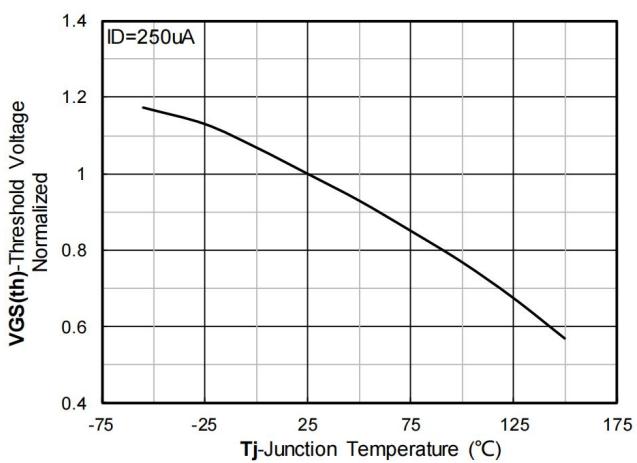


Figure 10. Normalized Threshold voltage

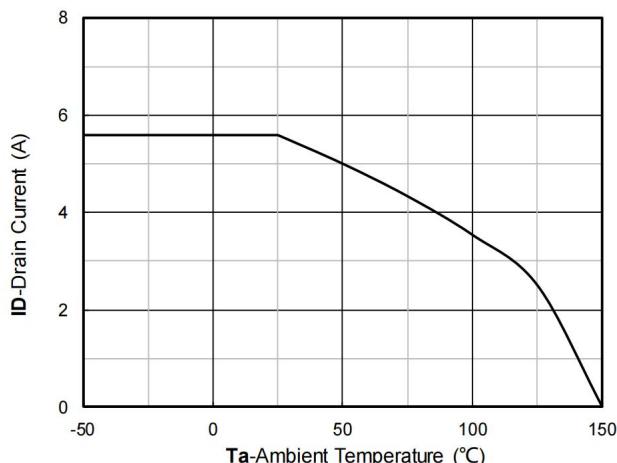


Figure 11. Current dissipation

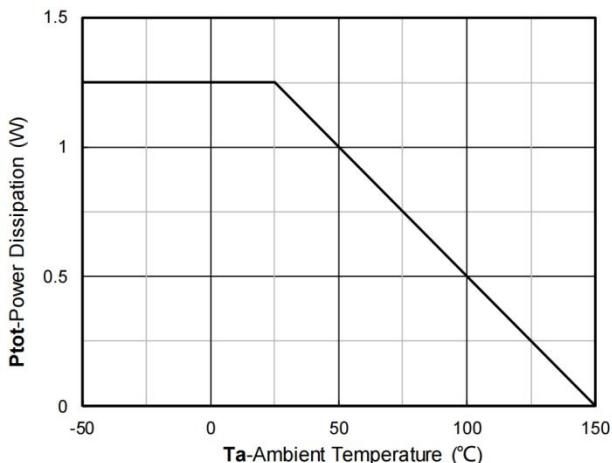


Figure 12. Power dissipation

Typical Characteristics

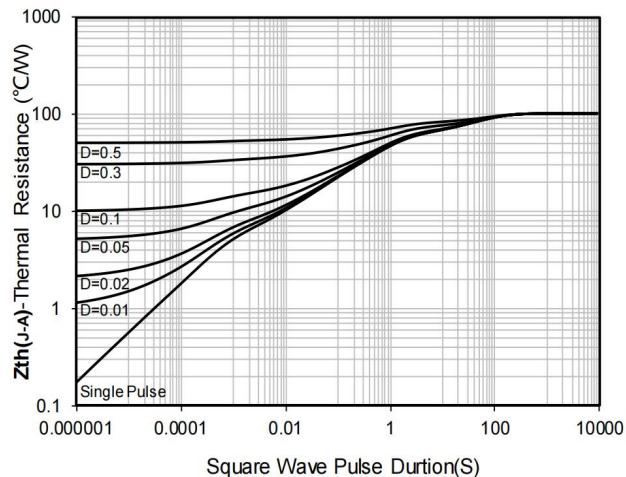


Figure 13. Maximum Transient Thermal Impedance

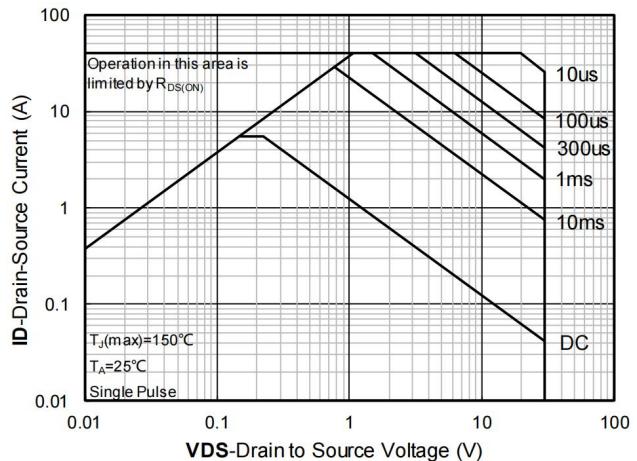
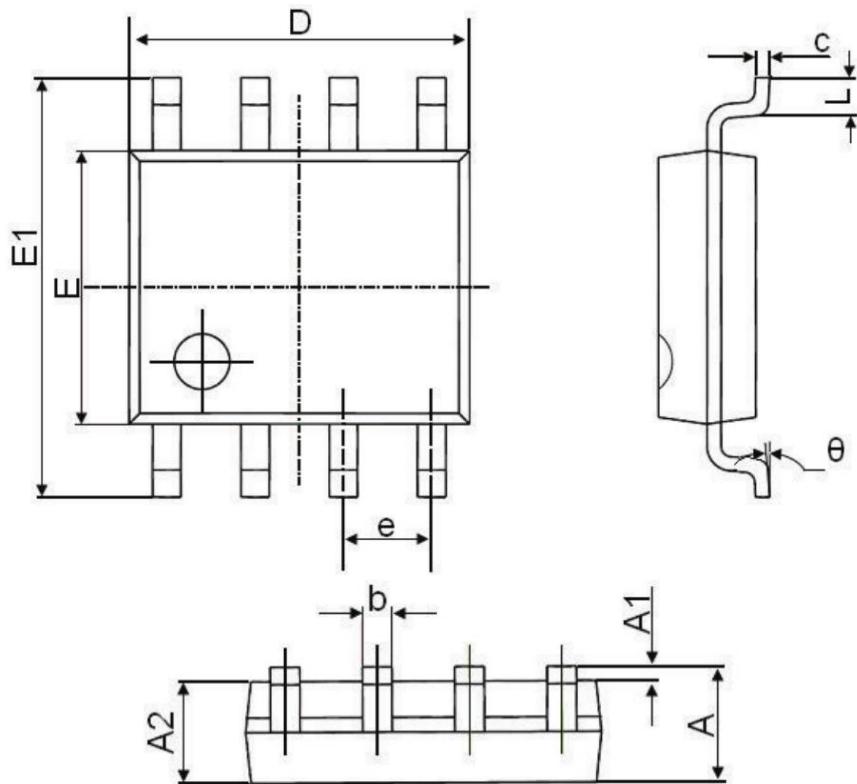


Figure 14. Safe Operation Area

SOP-8 Package Information



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	1.350	1.750	0.053	0.069
A1	0.100	0.250	0.004	0.010
A2	1.350	1.550	0.053	0.061
b	0.330	0.510	0.013	0.020
c	0.170	0.250	0.006	0.010
D	4.700	5.100	0.185	0.200
E	3.800	4.000	0.150	0.157
E1	5.800	6.200	0.228	0.244
e	1.270(BSC)		0.050(BSC)	
L	0.400	1.270	0.016	0.050
θ	0°	8°	0°	8°